



US 20180364535A1

(19) **United States**(12) **Patent Application Publication**
SHIINA(10) **Pub. No.: US 2018/0364535 A1**(43) **Pub. Date: Dec. 20, 2018**(54) **LIQUID CRYSTAL DISPLAY DEVICE**(52) **U.S. CL.**(71) Applicant: **Japan Display Inc.**, Minato-ku (JP)CPC **G02F 1/136286** (2013.01); **G02F 1/1368**
(2013.01); **G02F 1/133345** (2013.01); **G02F**
1/133512 (2013.01); **G02F 1/134363**
(2013.01); **H01L 27/127** (2013.01); **H01L**
27/1248 (2013.01); **G02F 2001/136295**
(2013.01); **G02F 2001/13685** (2013.01); **G02F**
2201/123 (2013.01); **H01L 27/1262** (2013.01);
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Jun. 19, 2017 (JP) 2017-119484

Publication Classification(51) **Int. Cl.**

G02F 1/1362	(2006.01)
G02F 1/1368	(2006.01)
G02F 1/1333	(2006.01)
G02F 1/1335	(2006.01)
G02F 1/1343	(2006.01)
H01L 27/12	(2006.01)

(57)

ABSTRACT

The purpose of the invention is to prevent the line shaped irregularity in brightness and to improve contrast. The representative structure is as follows. A liquid crystal display device comprising: a TFT substrate including a plural scan lines and a plural video signal lines, a counter substrate opposing to the TFT substrate, and a liquid crystal layer sandwiched between the TFT substrate and the counter substrate; wherein an interlayer insulating film is formed between the scan lines and the video signal lines, a groove like recess is formed in the interlayer insulating film superposing with the video signal line.

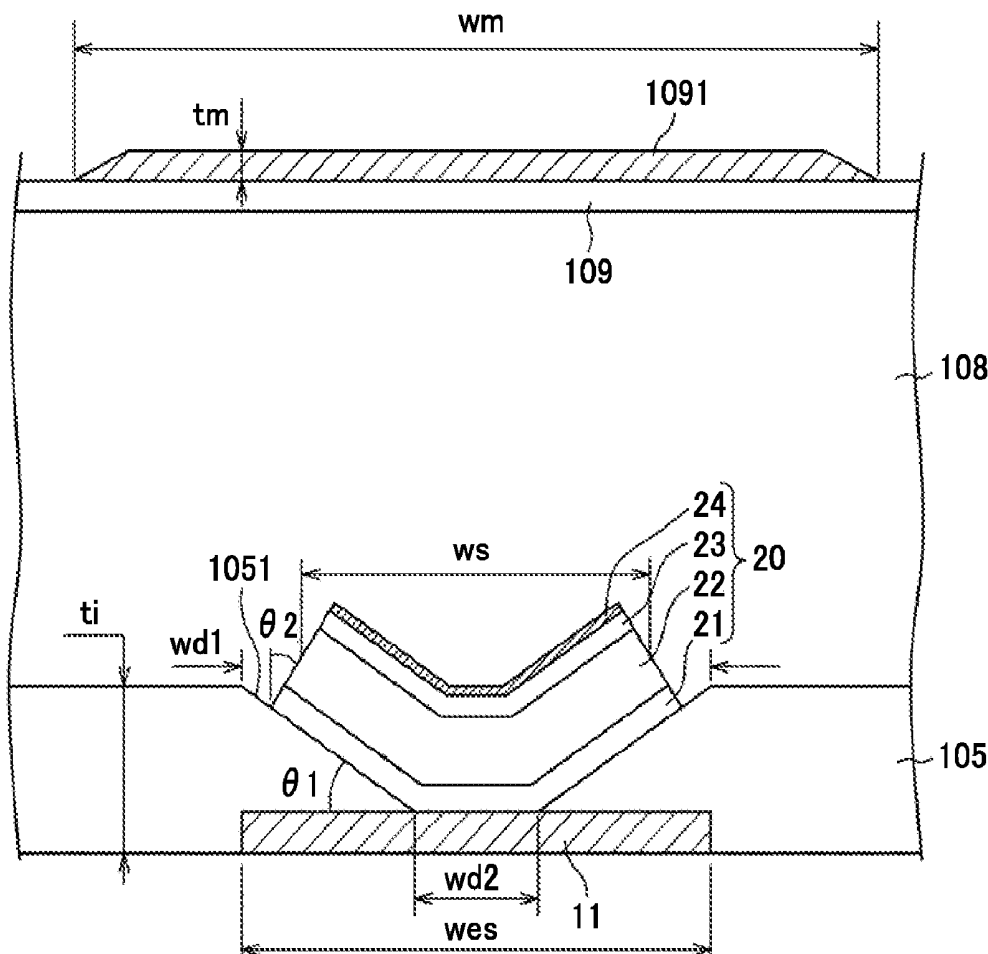


FIG. 1

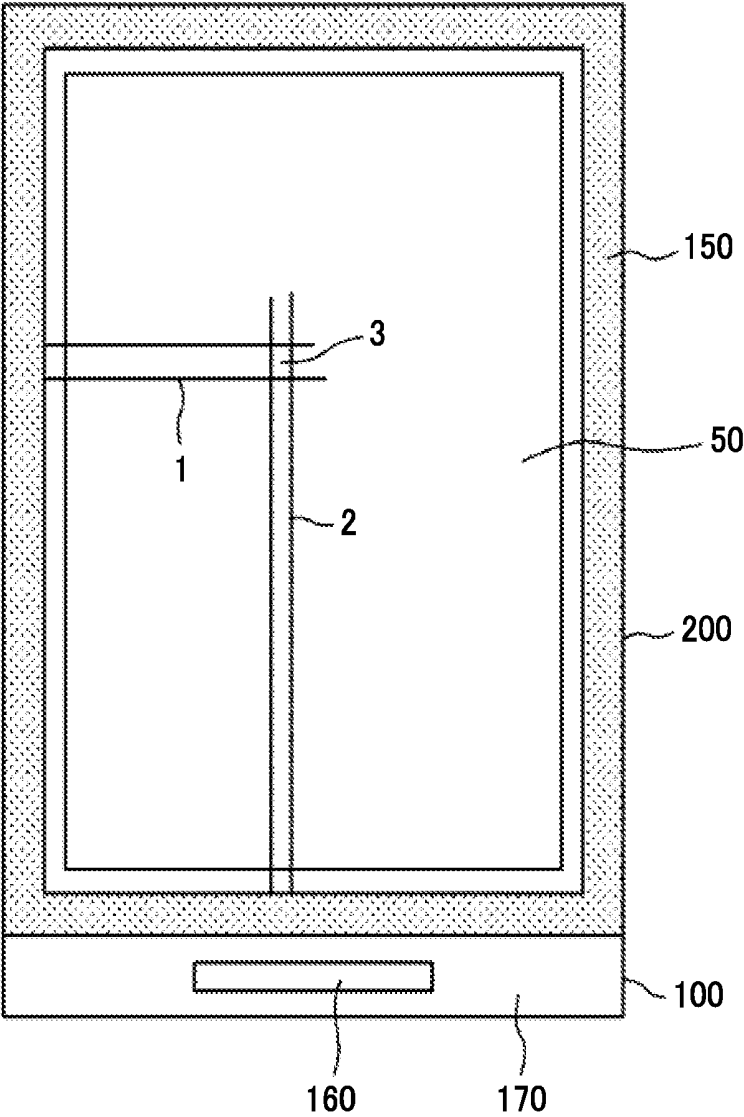


FIG. 2

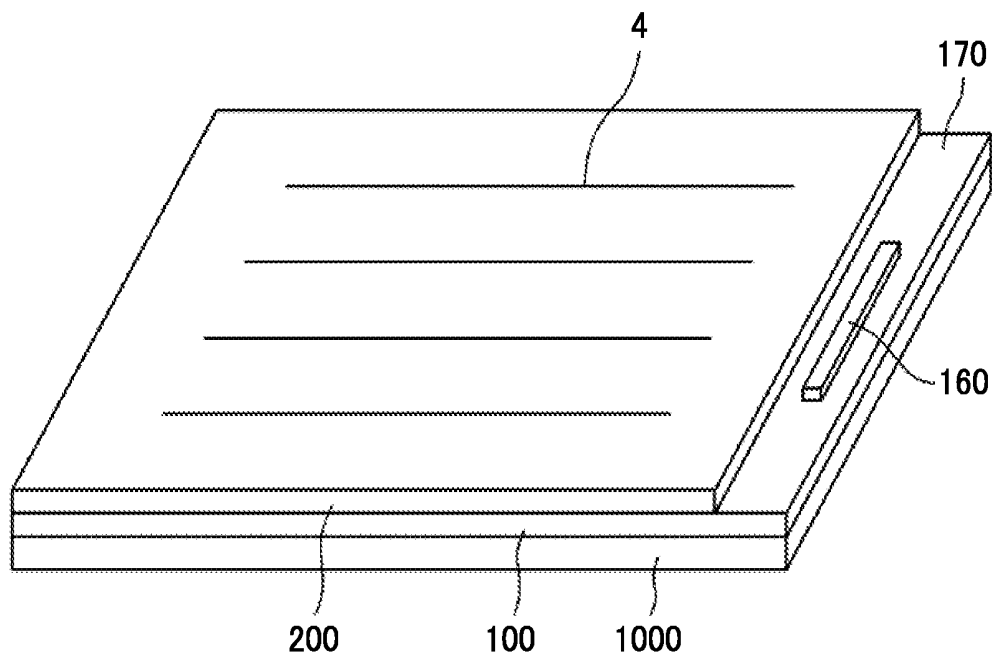


FIG. 3

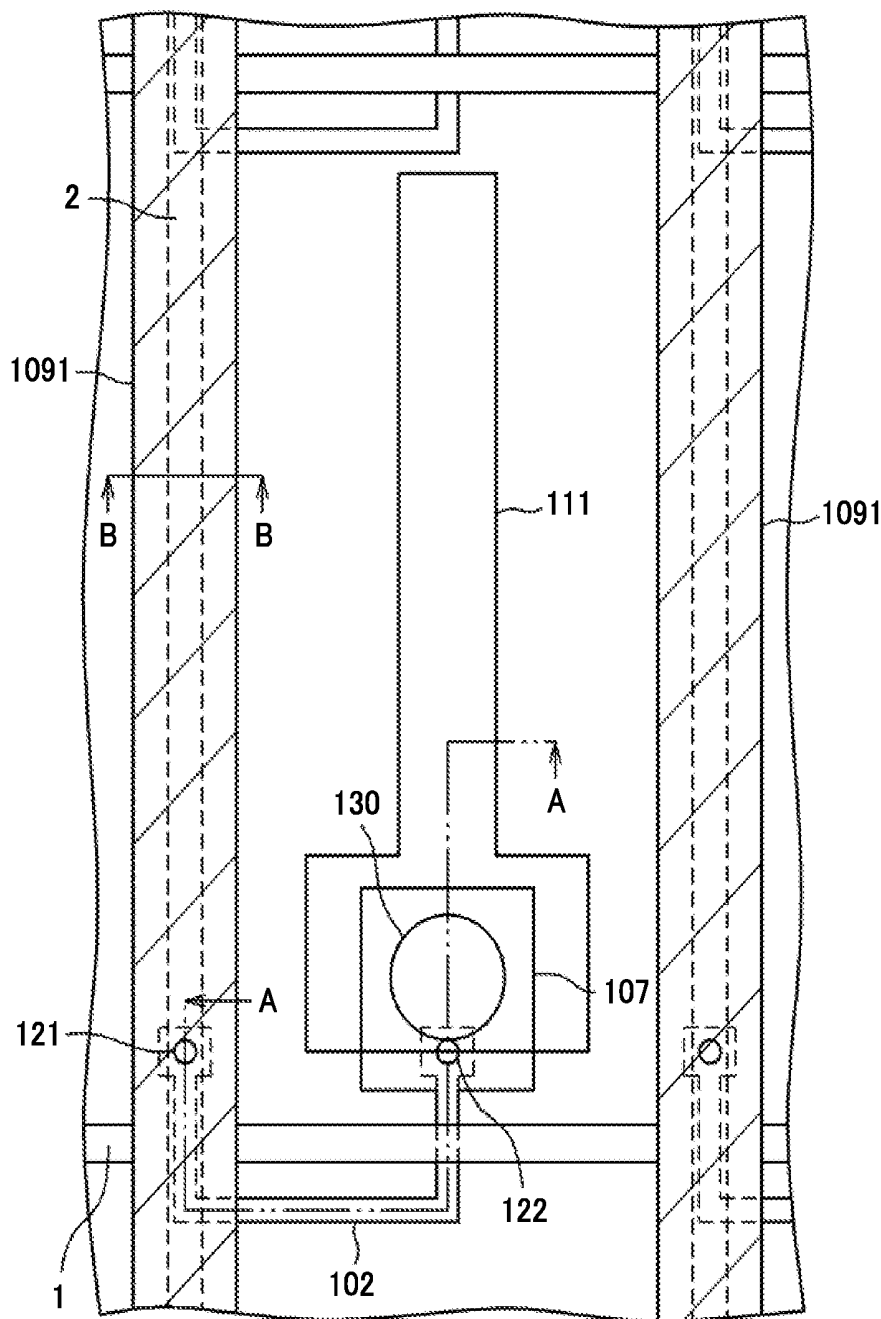


FIG. 5

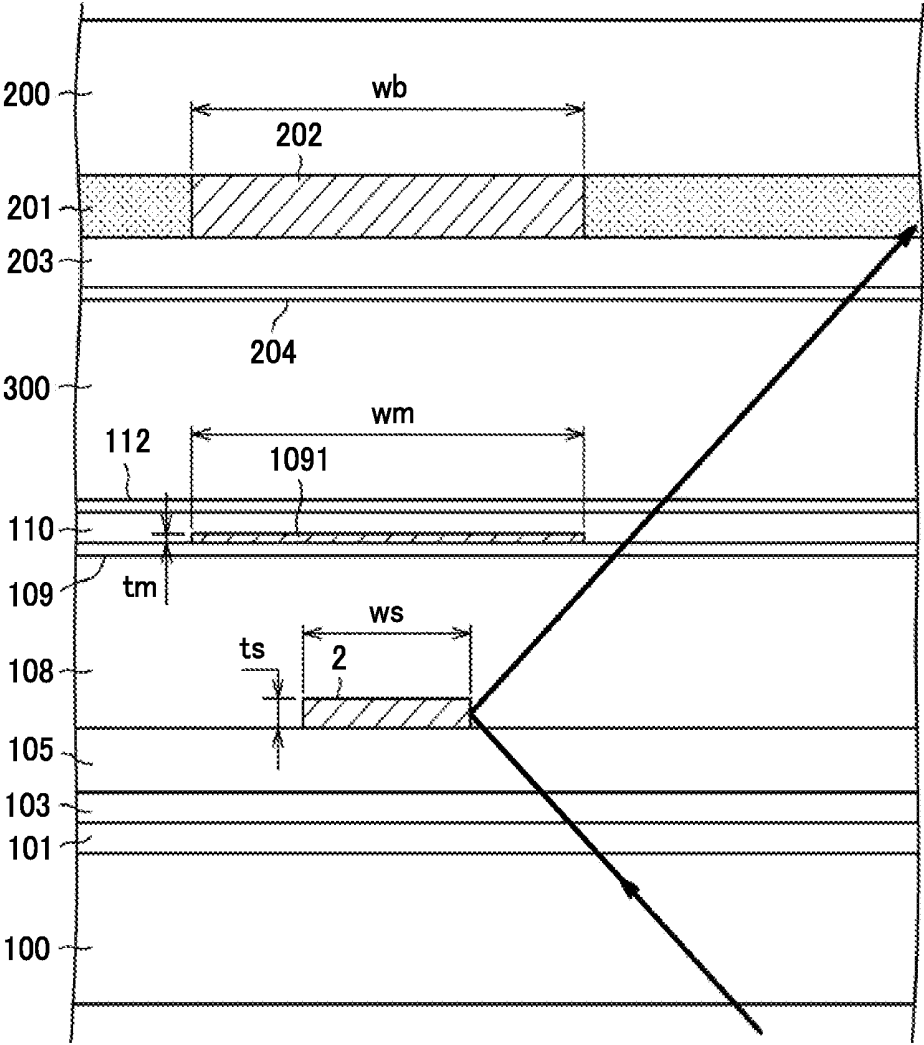


FIG. 6



FIG. 7

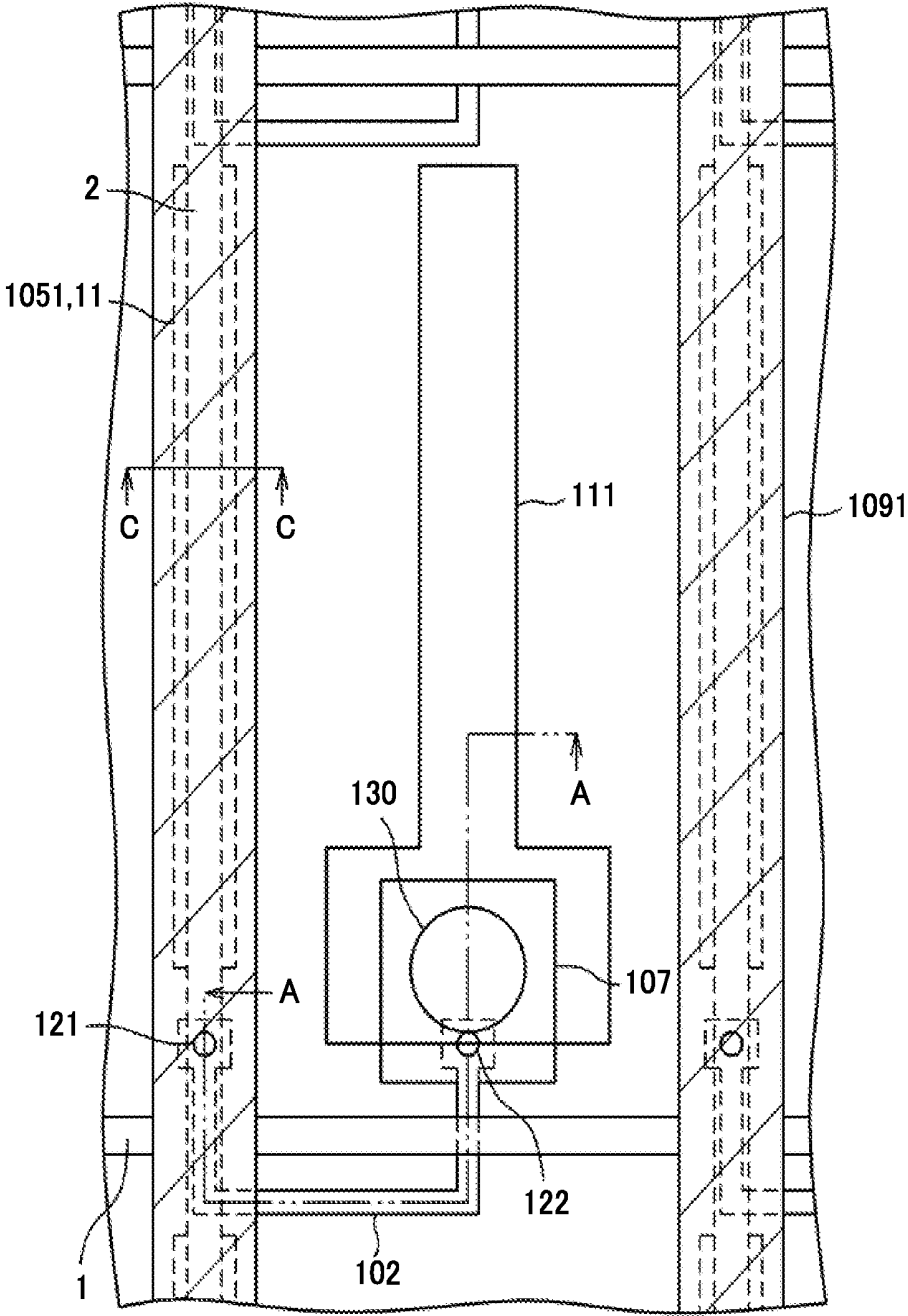


FIG. 8

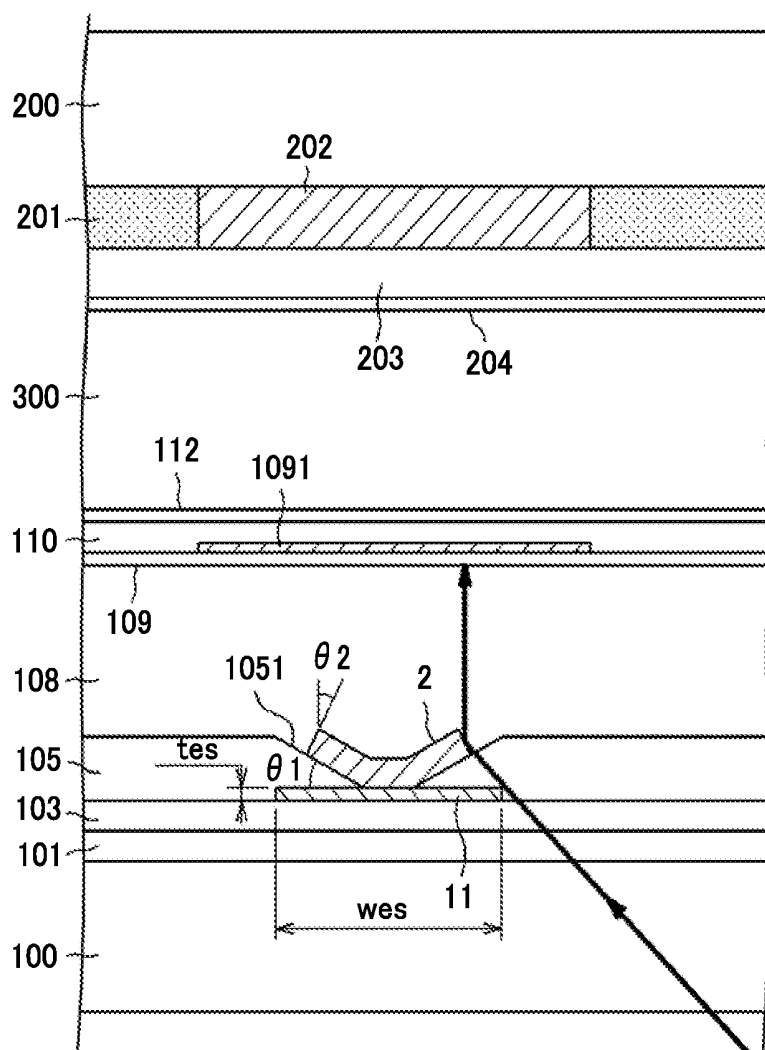


FIG. 9

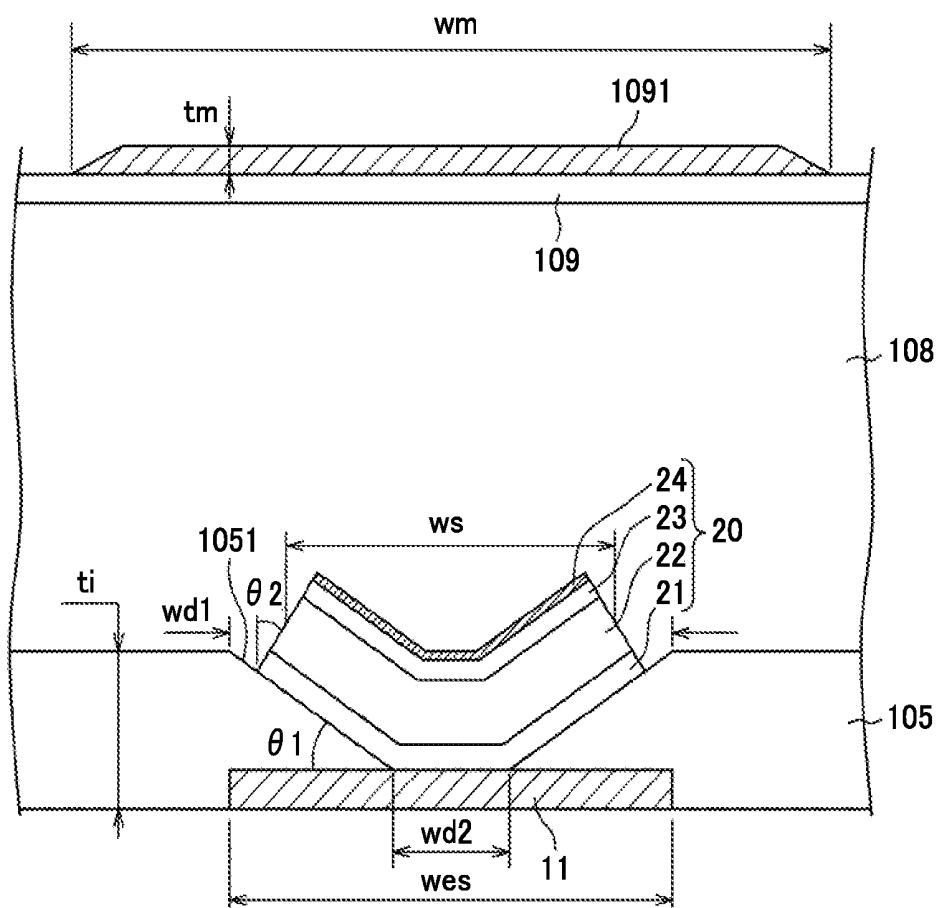


FIG. 10

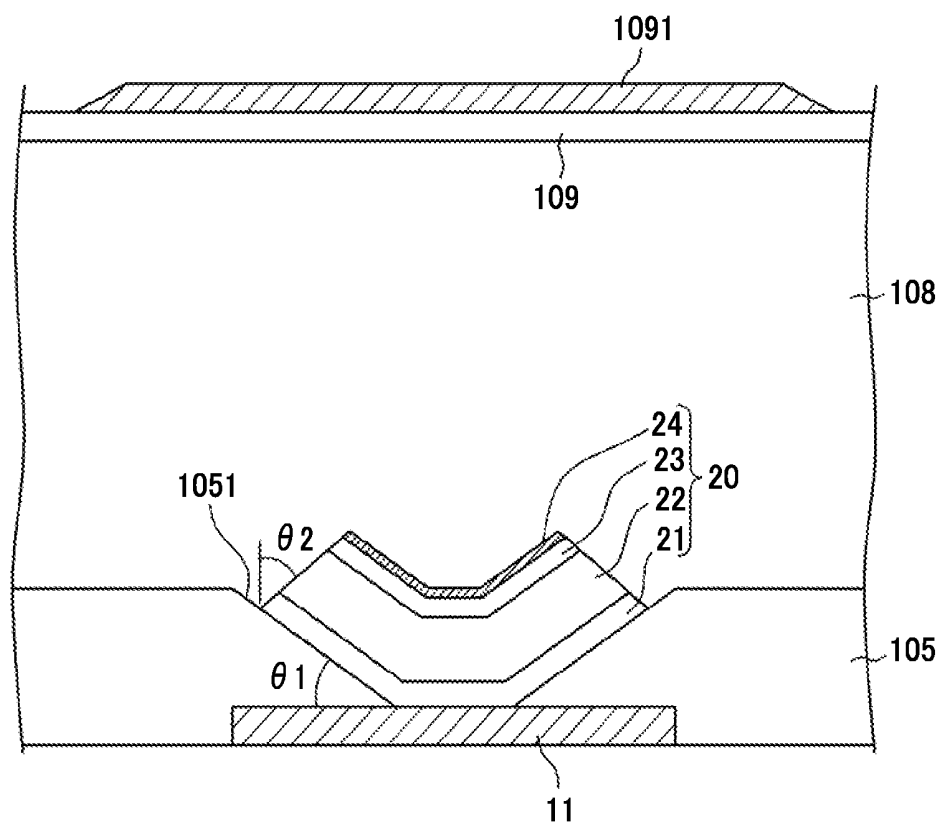
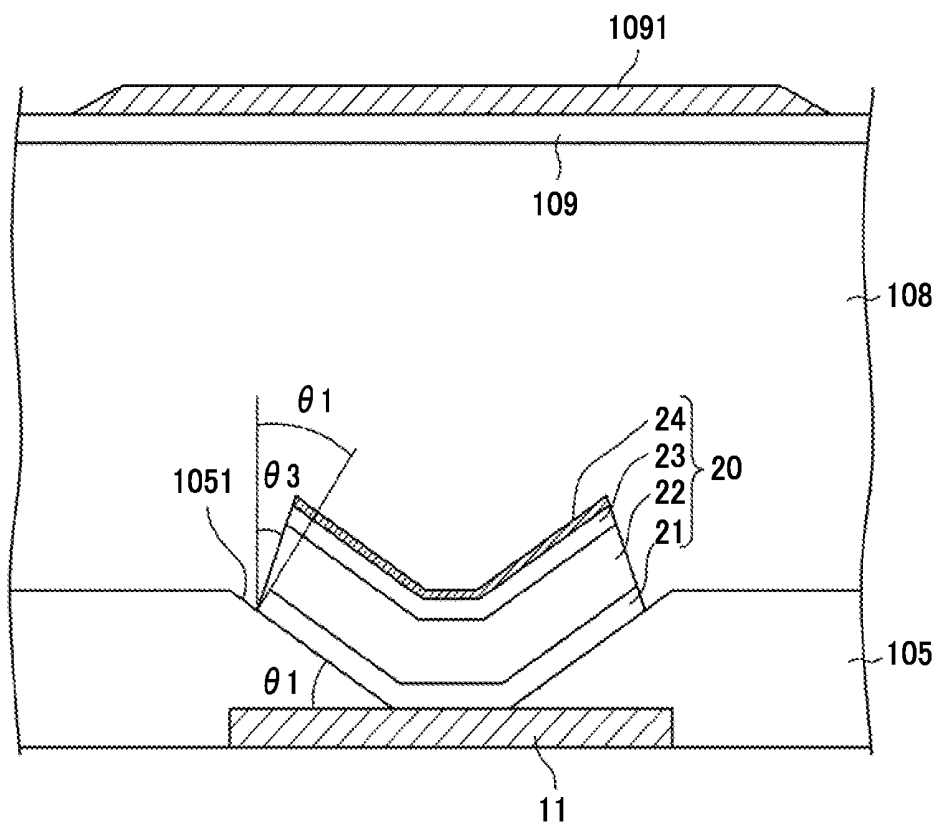


FIG. 11



LIQUID CRYSTAL DISPLAY DEVICE

CLAIM OF PRIORITY

[0001] The present application claims priority from Japanese Patent Application JP 2017-119484 filed on Jun. 19, 2017, the content of which is hereby incorporated by reference into this application.

BACKGROUND OF THE INVENTION

(1) Field of the Invention

[0002] The present invention relates to a display device, specifically a liquid crystal display device.

(2) Description of the Related Art

[0003] A liquid crystal display device has a TFT substrate, a counter substrate opposing to the TFT substrate, and a liquid crystal layer sandwiched between the TFT substrate and the counter substrate. The TFT substrate has plural pixels; each of the pixels has a pixel electrode and a thin film transistor (TFT). Each of the pixels is in an area surrounded by the scan lines and video signal lines. A transmittance of light in each pixel is controlled by liquid crystal molecules; thus, images are formed.

[0004] It is necessary to keep the electrical resistance of the video signal lines formed on the TFT substrate low to maintain a writing speed of the video signal data high to each of the pixels. On the other hand, it is difficult to widen the widths of the video signal lines to maintain the light transmittance rate of the pixels. Thus, thickness of the video signal line is made bigger.

[0005] On the other hand, if the thickness of the video signal lines is made bigger, reflection of light from the side surface of the video signal line becomes a problem. In other words, light from backlight comes from various directions to the video signal line; if the light from the backlight comes in an oblique direction to the surface of the TFT substrate, the light reflects at a side surface of the video signal line and goes to the display screen; sometimes this is conceived as a line shaped irregularities in brightness in the screen. This phenomenon renders degradation of contrast of a display in total.

[0006] The patent document 1 (Japanese patent laid open 2016-148807) discloses to make the width of the common metal wiring, which is superposed with the common electrode to decrease the resistance of the common electrode, wider than the width of the video signal line to stop the light reflected at the side surface of the video signal line (see e.g. FIG. 10).

SUMMARY OF THE INVENTION

[0007] The structure of the patent document 1 is to make the width of the common metal wiring, which is formed above the video signal line and along the video signal line, wide enough to stop the light reflected from the side surface of the video signal line. When the screen becomes high definition, however, it becomes difficult to make the width of the common metal wiring bigger.

[0008] Some of the display devices of high definition screen have a pixel pitch of the pixels of 30 μm (herein after micron) or less in a horizontal direction. As a result, it becomes difficult to make the width of the common metal wiring, which is formed above and along the video signal

line, wider. By the way, the pixel pitch means a pitch of individual subpixels e.g. between the red pixel, the green pixel or the blue pixel, not a pitch of the sets of pixels of the red pixel, the green pixel and the blue pixel in this specification.

[0009] The purpose of the present invention is to realize the structure that can suppress a degradation of contrast of the display without making a width of the common metal wiring substantially bigger than a width of the video signal line.

[0010] The present invention overcomes the above explained problem; the concrete structures are as follows.

[0011] (1) A liquid crystal display device comprising: a TFT substrate including a plural scan lines and a plural video signal lines, a counter substrate opposing to the TFT substrate, and a liquid crystal layer sandwiched between the TFT substrate and the counter substrate; wherein an inter-layer insulating film is formed between the scan lines and the video signal lines, a groove like recess is formed in the interlayer insulating film superposing with the video signal line.

[0012] (2) The liquid crystal display device according to (1); wherein a cross section of the groove like recess has a side wall, the edge of the video signal line exists on the side wall of the groove like recess.

[0013] (3) The liquid crystal display device according to (1); the edge of the video signal line has a side surface, the side surface tilts in a first angle to the normal direction of the TFT substrate so that the side surface faces a major surface of the liquid crystal layer in oblique direction.

BRIEF DESCRIPTION OF THE DRAWINGS

[0014] FIG. 1 is a plan view of the liquid crystal display device, in which the present invention is applied;

[0015] FIG. 2 is a perspective view of the liquid crystal display device;

[0016] FIG. 3 is a plan view of the display area of the liquid crystal display device;

[0017] FIG. 4 is a cross sectional view along A-A line in FIG. 3;

[0018] FIG. 5 is a cross sectional view along B-B line in FIG. 3;

[0019] FIG. 6 is a cross sectional view that shows the structure of the video signal line;

[0020] FIG. 7 is a plan view of the display area of the liquid crystal display device according to the present invention;

[0021] FIG. 8 is a cross sectional view along C-C line in FIG. 7;

[0022] FIG. 9 is an enlarged cross sectional view at the video signal line of FIG. 7;

[0023] FIG. 10 is an enlarged cross sectional view at the video signal line of FIG. 7 according to another example;

[0024] FIG. 11 is an enlarged cross sectional view at the video signal line of FIG. 7 according to yet another example;

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

[0025] The present invention will be described in detail referring to the following embodiments.

[0026] FIG. 1 is a plan view of a liquid crystal display device. In FIG. 1, the TFT substrate 100 and the counter substrate 200 adhere to each other via the sealing material

150; the liquid crystal is sandwiched between the TFT substrate **100** and the counter substrate **200**. The TFT substrate **100** is made bigger than the counter substrate **200**; the portion of the TFT substrate **100** that doesn't overlap with the counter substrate **200** is the terminal area **170**. In the terminal area **170**, the driver IC **160** that drives the liquid crystal panel is installed; and the terminals for connection with a flexible wiring substrate are formed. The flexible wiring substrate is for supplying powers, video signals, scan signals, and so on, to the liquid crystal display panel. In this specification, generally, the liquid crystal display device means to include the liquid crystal panel and the backlight; however, in some cases the liquid crystal display device may mean only the liquid crystal panel.

[0027] In FIG. 1, the scan lines **1** extend in a lateral direction, and arranged in a longitudinal direction. The video signal lines **2** extend in the longitudinal direction, and arranged in the lateral direction. The pixel **3** is formed in the area surrounded by the scan lines **1** and the video signal lines **2**. A pixel electrode is formed in each of the pixels **3**. In a high definition display, the pitch of the pixels in the direction that the scan line extends is as small as 30 μm (herein after micron). A backlight is set at rear side of the TFT substrate **100**.

[0028] FIG. 2 is a perspective view of the liquid crystal display device depicted in FIG. 1. The backlight **1000** is set on the back of the liquid crystal display panel, which is constituted by the TFT substrate **100** and the counter substrate **200**. In the liquid crystal display panel, the images are formed by controlling a transmittance of the light from the backlight **1000** in each of the pixel. The light from the backlight **1000** is not collimated, thus, the light from the backlight **1000** impinges to the liquid crystal panel in various directions.

[0029] In FIG. 2, the video signal lines extend in the direction of long side of the TFT substrate **100**. In the high definition displays, a thickness of the video signal line becomes thick to maintain the transmittance of light in the pixel and to keep the electrical resistance of the video signal line low. As a result, the light from the backlight **1000** tends to reflect at the side surface of the video signal line **2**.

[0030] If the light reflected from the side surface of the video signal line **2** goes to the screen, it becomes a leak of light; consequently, the contrast of the images in the display is degraded. Further, since the reflection from the side surface of the video signal line **2** occurs along the video signal line **2**, the line shaped irregularity in brightness appears along the video signal line as depicted by notation **4** in FIG. 2. FIG. 2 is an example that four line shaped irregularities in brightness appear. That line shaped irregularities aggravate the impression of the screen. The present invention prevents the reflection from the video signal line, thus, prevents the line shaped irregularities as depicted by notation **4** in FIG. 2.

[0031] FIG. 3 is a plan view of the pixel as a comparative example to the present invention. FIG. 3 is an example of IPS (In Plane Switching) type liquid crystal display device. In FIG. 3, the scan lines **1** extend in a lateral direction and arranged in a longitudinal direction; the video signal lines **2** extend in the longitudinal direction and arranged in the lateral direction; the pixel electrode **111** is formed in the area surrounded by the scan lines **1** and the video signal lines **2**. The semiconductor layer **102** connects with the video signal line **2** via through hole **121**, extends under the video signal

line **2**. When the semiconductor layer **102** goes through under the scan line **1**, the first TFT is formed at the place where the semiconductor layer **102** and the scan line **1** overlap. The semiconductor layer **102** bends crank like, and extends, through under the scan line **1**, to the pixel electrode **111**, wherein the second TFT is formed at the region where the semiconductor layer **102** and the scan line **1** overlap.

[0032] The semiconductor layer **102** connects with the source electrode **107** via the through hole **122**. The source electrode **107** connects with the pixel electrode **111** via the through hole **130**. The diameter of the through hole **130** is big because it is formed in the thick organic passivation film.

[0033] In FIG. 3, the pixel electrode **111** forms an electric field between the plane shaped common electrode sandwiching the capacitive insulating film, which will be explained later, to rotate the liquid crystal molecules, thus, controls the transmittance of the light from the backlight. In FIG. 3, since the pitch of the pixels in the direction the scan line extends is as small as 30 micron, the pixel electrode **111** is one stripe shaped; however, when the size of the pixel becomes bigger, the pixel electrode **111** can be a comb like electrode, which has a slit inside.

[0034] Since the pitch of the pixels is small, the width of the video signal line **2** cannot be bigger to maintain the transmittance of the pixel. The resistance of the video signal line **2**, however, must be low to keep the writing speed of the video signals high. Consequently, the thickness of the video signal line **2** becomes thick. As explained later, however, a reflection of light from the backlight at the side surface of the video signal line **2** becomes a problem.

[0035] FIG. 4 is a cross sectional view along A-A line of FIG. 3. In FIG. 4, the undercoat **101** is formed on the TFT substrate **100** formed by e.g. glass. If the liquid crystal display device is bendable, a thickness of the glass substrate is 0.2 mm or less, or the TFT substrate **100** is formed by resin, like polyimide.

[0036] The undercoat **101** prevents the semiconductor layer **102**, which is formed later, from being contaminated by impurities from the glass substrate **100** or the resin substrate **100**. The undercoat **101** is generally a laminated film of the silicon nitride (herein after SiN) film and the silicon oxide (herein after SiO) film. The semiconductor layer **102** is formed on the undercoat **101**. The semiconductor layer **102** is formed as follows. The a-Si is formed by CVD (Chemical Vapor Deposition); then the excimer laser is irradiated to the a-Si to transform the a-Si to the Poly-Si. By the way, the undercoat **101**, which is constituted by the SiN film and the SiO film, and the a-Si, which is transformed to be the semiconductor layer are formed by CVD continuously.

[0037] The semiconductor layer **102** is patterned; then the gate insulating film **103** is formed on the semiconductor layer **102**. The gate insulating film **103** is a SiO film that is formed by CVD using (Tetraethyl orthosilicate) as the material. The gate electrode **104** is formed on the gate insulating film **103**. The gate electrode **104** is made of e.g. MoW (Molybdenum Tungsten) alloy, which is formed by sputtering, and patterned. In the structure of FIG. 3, the scan line works as the gate electrode **104**, wherein two TFTs are formed when the semiconductor layer **102** goes through under the scan line **1** twice; in other words, the TFT of two gate electrodes **104** is formed in FIG. 4.

[0038] After the gate electrode **104** is patterned, the ion implantation of P (Phosphorus) or B (Boron) is applied to

the semiconductor layer **102** using the gate electrode **104** as the mask to give conductivity to the semiconductor layer **102** except the portion that is covered by the gate electrode **104**. As a result, the drain region **1021** and the source region **1022** are formed in the semiconductor layer **102**.

[0039] After that, the interlayer insulating film **105** is formed covering the gate electrode **104** by the SiN film or the SiO film, or the laminated film of the SiN film and the SiO film. The interlayer insulating film **105** can be formed by CVD. Subsequently, the through hole **121** is formed in the interlayer insulating film **105** and the gate insulating film **103** to connect the drain region **1021** of the semiconductor **102** and the video signal line **2**. In this case, the video signal line **2** is a drain electrode **106**. On the other hand, the source region **1022** is connected to the source electrode **107** via through hole **122** formed in the interlayer insulating film **105** and the gate insulating film **103**.

[0040] The organic passivation film **108** is formed by e.g. acrylic resin covering the drain electrode **106** and the source electrode **107**. Since the organic passivation film **108** also works as a flattening film, it is formed as thick as 2 to 4 micron. Organic passivation film **108** is formed by photo-sensitive resin; thus, an additional photoresist process is not necessary to form the through hole **130**. Since the material for the organic passivation film **108** is a positive photosensitive material, the through hole **130** is formed where the light is irradiated. In the meantime, other than acrylic resin, the organic passivation film **108** can be made of silicone resin, polyimide, etc.

[0041] The common electrode **109** is formed by transparent oxide conductive film as ITO (Indium Tin Oxide) in a plane shape on the organic passivation film **108**. The common electrode **109** is formed continuously in plural pixels in common; however, it is not formed in the through hole **130**. After the common electrode **109** is patterned, the capacitive insulating film **110** is formed by SiN covering the common electrode **109**. The capacitive insulating film **110** is formed by CVD. Since the capacitive insulating film **110** is formed after the organic passivation film **108** is formed, it cannot be formed by high temperature process; thus, it is formed low temperature CVD as **200** (herein after centigrade).

[0042] The pixel electrode **111** is formed by transparent oxide conductive film as ITO (Indium Tin Oxide) in a comb shape or a stripe shape on the capacitive insulating film **110**. The insulating film **110**, which is between the common electrode **109** and the pixel electrode **111**, forms a holding capacitance, thus, it is called the capacitive insulating film **110**.

[0043] The through hole is formed in the capacitive insulating film **110** in the through hole **130**, which is formed in the organic passivation film **108**, to connect the pixel electrode **111** and the source electrode **107**.

[0044] The alignment film **112** is formed covering the pixel electrode **111** and the capacitive insulating film **110**. The alignment film **112** determines the initial alignment of the liquid crystal molecules **301**; the alignment process for the alignment film **112** is made by rubbing method or optical alignment method. In the IPS type liquid crystal display device, the optical alignment process is more suitable. When the video signal is applied to the pixel electrode **111**, a line of force is generated between the pixel electrode **111** and the common electrode **109** as depicted by arrows in FIG. 4, as a result, the liquid crystal molecules **301** are rotated, con-

sequently, transmittance of the liquid crystal layer **300** is changed; thus, display images are formed.

[0045] In FIG. 4, the counter substrate **200** is set opposing to the TFT substrate **100** sandwiching the liquid crystal layer **300**. If the display device is required to be flexible, the counter substrate **200** can be made of resin, like polyimide. The color filter **201** and the black matrix **202** are formed on the inside surface of the counter substrate **200**. The color filter **201** is formed at the portion where the light from the backlight is controlled to form the display images. On the other hand the black matrix **202** is formed at the portion where controlling of the light from the backlight is difficult, as e.g. the place where the through hole **130** is formed; thus, leak of the light from the backlight is suppressed.

[0046] The overcoat film **203** made of transparent organic material as e.g. acrylic is formed covering the color filter **201** and the black matrix **202**. The alignment film **204** is formed on the overcoat film **203**. The alignment process for the alignment film **204** is made by rubbing method or optical alignment method as the alignment film **112**.

[0047] FIG. 5 is cross sectional view along the line A-A in FIG. 3. In FIG. 5, the undercoat **101**, gate insulating film **103**, and the interlayer insulating film **105** are formed on the TFT substrate **100** in this order. The video signal line **2** is formed on the interlayer insulating film **105**. The video signal line **2** is made thick to decrease the resistance. The thickness of the video signal line **2** is e.g. 683 nm, the width w_s is e.g. 1.75 micron. The organic passivation film **108** is formed covering the video signal line **2**.

[0048] The common electrode **109** is formed by ITO in a plane shape on the organic passivation film **108**. The common metal wiring **1091** is formed on the common electrode **109**, and above the video signal line **2**. Since the resistance of the common electrode **109**, which is made of ITO, is high, the common metal wiring **1091** is formed to decrease the resistance of the common electrode **109**. The width w_m of the common metal wiring **1091** is e.g. 4.5 micron; the thickness is e.g. 78 nm. The thickness of the common metal wiring **1091** can be chosen in a range of 20 nm to 130 nm. The capacitive insulating film **110** is formed covering the common electrode **109** and the common metal wiring **1091**; the alignment film **112** is formed on the capacitive insulating film **110**.

[0049] In FIG. 5, the counter substrate **200** is formed opposing to the TFT substrate **100** sandwiching the liquid crystal layer **300**. The color filter **201** and the black matrix **202** are formed on the inside surface of the counter substrate **200**; the overcoat film **203** is formed on the color filter **201** and the black matrix **202**; the alignment film **204** is formed on the overcoat film **203**. The width w_b of the black matrix **202** is approximately the same as the width w_m of the common metal wiring **1091** or slightly wider than the width w_m of the common metal wiring **1091**. In FIG. 5, the width w_b of the black matrix is e.g. 5 micron.

[0050] FIG. 6 is a cross sectional view that shows the structure of the video signal line **2**. The video signal line **2** is constituted by four layers. The lower most layer is the base metal **21**, which is made of e.g. Titan (Ti) layer, the thickness t_1 is e.g. 130 nm. The Aluminum (Al) layer **22** is formed on the base metal **21**. The Aluminum layer **22** is actually an alloy that includes a slight amount of silicon (Si). The thickness t_2 of the Aluminum layer **22** is e.g. 500 nm. The cap metal layer **23** is formed on the Aluminum layer **22** by e.g. Ti at a thickness of t_3 , which is e.g. 45 nm. The

anti-reflection film **24** is formed on the cap metal layer **23** by e.g. Titan Nitride (TiN). The anti-reflection film **24** is for preventing the reflection of external light; the thickness of **t4** of the anti-reflection film **24** is e.g. 8 nm.

[0051] Back to FIG. 5, the light from the backlight, which is disposed on the back of the liquid crystal display panel, is not necessarily collimated; consequently, light impinges to the liquid crystal display panel in various directions. The arrow in FIG. 5 depicts that the light from the backlight impinges to the liquid crystal display panel in an oblique direction. As depicted in FIG. 5, the light impinges in an oblique direction to the liquid crystal display panel is reflected at the side surface of the video signal line **2**, and goes to the screen.

[0052] The light depicted by the arrow deteriorates the contrast of the screen. Further, as explained in FIG. 2, the reflected light interferes with each other, and thus, tends to form the line shaped irregularity in brightness in the screen. The effects of the reflected light can be avoided if the reflected light is shaded by the common metal wiring **1091** formed on the common electrode **109**. However, if the width of the common metal wiring **1091** becomes wider to stop the reflected light, the opening ratio of the pixel decreases.

[0053] FIG. 7 is a plan view of the pixel structure in the present invention. FIG. 7 differs from FIG. 3 in that the groove like through hole **1051** is formed in the interlayer insulating film **105** under the video signal line **2**. Further, the etching stopper **11** is formed in approximately the same width as the groove like through hole **1051** on the same layer as the gate electrode **104** (scan line **1**).

[0054] In FIG. 7, the groove like through hole **1051** and the etching stopper **11** are formed at a position that doesn't overlap with the semiconductor layer **102** in a plan view. The reason is that: the etching stopper **11** is formed by the metal layer that is simultaneously formed with the scan line **1**; thus, the etching stopper **11** is separated from the scan line **1** to be insulated from the scan line **1**. Since the etching stopper **11** cannot be formed in the separating area, the groove like through hole **1051** cannot be formed near the scan line **1**, either. However, even the groove like through hole **1051** is not formed near the scan line as depicted in FIG. 7, the black matrix **202** is formed on the counter substrate **200** overlapping with the scan line **1** in a plan view; thus, effects of the light reflected at the surface of the video signal line **2** can be avoided.

[0055] FIG. 8 is a cross sectional view along the line C-C in FIG. 7. FIG. 9 is an enlarged view near the video signal line **2** in FIG. 8. FIGS. 8 and 9 differ from FIG. 5 in that the groove like through hole **1051** is formed in the interlayer insulating film **105** where the video signal line **2** is disposed. The interlayer insulating film **105**, which has an e.g. approximately 650 nm thickness, is a laminated film of a SiN film (thickness of 250 nm) and a SiO film (thickness of 400 nm). The cross section of the groove like through hole **1051** has a bottom and a tapered side wall; the edge of the video signal line **2** exists on the side wall of the groove like through hole **1051**. The width **wd1** of the upper part of the groove like through hole **1051**, which is e.g. 2 micron, is slightly wider than the width **ws** of the video signal line **2**. The etching stopper **11**, which is formed on the same layer as the scan line **1**, exists at the bottom of the groove like through hole **1051**, consequently, the video signal line **2** and the etching stopper **11** are electrically connected.

[0056] The role of the etching stopper **11** is to prevent the gate insulating film **103**, which is formed under the interlayer insulating film **105**, from being etched when the groove like through hole **1051** is formed in the interlayer insulating film **105** by etching. Since the etching stopper **11** is simultaneously formed with the scan line **1**, it is formed by the same material as the scan line **1** as e.g. Molybdenum Tungsten alloy (MoW) in a thickness **tes** of e.g. 250 nm.

[0057] In FIGS. 8 and 9, the width **wes** of the etching stopper **11** is the same as the upper width **wd1** of the groove like through hole **1051**. However, since the role of the etching stopper **11** is to prevent the gate insulating film **103** from being etched when the interlayer insulating film is etched, the width **wes** can be as narrow as the width **wd2** of the bottom of the groove like through hole **1051**. If the width **wes** of the etching stopper **11** is too wide, it causes a decreasing of the opening ratio; thus, the width **wes** is preferably equal to or less than the width of the upper width **wd1** of the groove like through hole **1051**.

[0058] The feature of the present embodiment is that the edge of the video signal line **2** in the width direction is on the side wall of the groove like through hole **1051**, consequently, the edge of the video signal line **2** is oblique in regard to the major surface of the TFT substrate **100**. For example, if an angle of inclination of the side wall of the groove like through hole **1051** is $\theta 1$ with respect to the major surface of the TFT substrate **100**, the side surface of the video signal line **2** tilts with respect to the normal direction of the TFT substrate **100** in an angle of $\theta 2$, which is the same as $\theta 1$.

[0059] Certain effect can be expected if the angle of $\theta 2$, which is a tilt angle of the video signal line **2** with respect to the normal direction of the TFT substrate **100**, is larger than zero; however, it is preferable that the angle of $\theta 2$ is 15 degree or more to get an apparent effect. In this case, according to the structure of FIG. 9, an angle of inclination $\theta 1$ of the groove like through hole **1051** is also 15 degree or more. However, if the angle of $\theta 2$ is too big, a reflection by the side surface of the video signal line **2** against the light that comes from the liquid crystal layer side tends to be a problem. Therefore, the angle of $\theta 2$ is preferably 45 degree or less.

[0060] In addition to that, when the edge of the video signal line **2** is set on the side wall of the groove like through hole **1051**, fabrication of the video signal line **2** or the groove like through hole **1051** becomes difficult if the inclination $\theta 1$ of the groove like through hole **1051** is too big. Consequently, the angle of inclination $\theta 1$ is preferably 45 degree or less. Therefore, the range of the angle of inclination $\theta 1$ is preferably between 15 degree and 45 degree.

[0061] In FIG. 9, the organic passivation film **108** is formed over the video signal line **2**; the common electrode **109** is formed on the organic passivation film **108**; the common metal wiring **1091** is formed on the common electrode **109** to decrease the electrical resistance of the common electrode **109**. The width **wm** of the common metal wiring **1091** is wider than the width **ws** of the video signal line **2**; the width **wm** of the common metal wiring **1091** is e.g. 4.5 micron. If the thickness of the common metal wiring **1091** is big, a reflection from the side surface becomes a problem as explained with respect to the video signal line **2**; however, the thickness **tm** of the common metal wiring **1091** is e.g. 78 nm, which is much thinner than that of the video

signal line 2, thus, the influence of the reflection from the side surface of the common metal wiring 1091 is not big.

[0062] A thickness of the common metal wiring may become as thick as approximately 130 nm when the common metal wiring 1091 is used as an electrode for a touch panel; even in that case, the thickness of the metal wiring 1091 is approximately one fifth of the thickness of the video signal line 2; thus, the influence is small. In addition, if a taper etching is applied to the common metal wiring 1091 in some extent as depicted in FIG. 9, the influence of the reflection from the side surface of the common metal wiring 1091 can be further decreased.

[0063] In such structures, it is evaluated a path of light from the backlight that impinges to the liquid crystal display panel in an oblique direction as depicted by the arrow, and reflected at the side surface of the video signal line 2. In the case of FIG. 5, the reflected light is not stopped by the common metal wiring 1091 that is formed above the video signal line 2. In the case of the structure of FIGS. 8 and 9, however, the side surface of the video signal line 2 inclines, consequently, the reflected light comes closer the normal line of the TFT substrate 100 as depicted by the arrow in FIG. 9; thus, the reflected light is stopped by the common metal wiring 1091 or by the black matrix 202, and doesn't go to the screen. Therefore, the line shaped irregularity in brightness, which appears along the video signal line, can be avoided; further, aggravation of the contrast of the screen can be avoided. By the way, in FIG. 8, the common metal wiring 1091 is formed at the side nearer to the liquid crystal layer 300 with respect to the common electrode 109; however, this invention is applicable, too, to the structure that the common metal wiring 1091 is formed under the common electrode 109 (namely at the side of the organic passivation film 108).

[0064] FIG. 10 is a cross sectional view that the side surface of the video signal line 2 is made by taper etching. The structure of FIG. 10 is the same as the structure of FIG. 9 except the shape of the side edges of the video signal line 2. In FIG. 10, the angle of θ_2 , which is a tilt angle of the side surface of the video signal line 2 with respect to the normal direction of the TFT substrate 100, is bigger than the angle of θ_1 , which is an angle of inclination of the side wall of the groove like through hole 1051 formed in the interlayer insulating film 105, in an amount of an angle of taper etching in the side surface of the video signal line 2. As a result, the influence of the reflection of light from backlight is further reduced compared with the case in FIG. 9.

[0065] FIG. 11, in reverse to FIG. 10, is a cross sectional view that the edge of the video signal line 2 is etched in a reverse taper. The structure of FIG. 11 is the same as the structure of FIG. 9 except the shape of the side edges of the video signal line 2. In FIG. 11, the angle of θ_3 , which is a tilt angle of the side surface of the video signal line 2 with respect to the normal direction of the TFT substrate 100, is smaller than the angle of θ_1 , which is an angle of inclination of the side wall of the groove like through hole 1051 formed in the interlayer insulating film 105, in an amount of an angle of reverse taper etching in the side surface of the video signal line 2.

[0066] Even in this structure, as far as the angle of θ_3 is bigger than zero, similar effects of the invention is attainable. Concretely, if the angle of θ_3 is 15 degree or more, the same effects as explained in FIGS. 9 and 10 are attainable. Further, if the edge of the video signal line 2 is on the side

wall of the groove like through hole 1051, it is easier to make by etching the cross section of the video signal line 2 in FIG. 11 than the cross section of the video signal line 2 in FIGS. 9 and 10, in some occasions.

[0067] In FIGS. 3 and 7, the video signal line 2 extends in a perpendicular direction to the scan line 1; however, the present invention can also be applied when an extending direction of the video signal line 2 tilts some angle with respect to the direction perpendicular to the scan line 1.

[0068] The above explanation was made under the premise that the common metal wiring 1091 exists; however, when the common metal wiring doesn't exist, the black matrix 202 formed on the counter substrate 200 can have a role as the common metal wiring 1091. Thus, the present invention is applicable even when the common metal wiring 1091 doesn't exist.

What is claimed is:

1. A liquid crystal display device comprising: a TFT substrate including a plural scan lines and a plural video signal lines, a counter substrate opposing to the TFT substrate, and a liquid crystal layer sandwiched between the TFT substrate and the counter substrate,

wherein an interlayer insulating film is formed between the scan lines and the video signal lines,

a groove like recess is formed in the interlayer insulating film superposing with the video signal line.

2. The liquid crystal display device according to claim 1, wherein a cross section of the groove like recess has a side wall,

the edge of the video signal line exists on the side wall of the groove like recess.

3. The liquid crystal display device according to claim 1, the edge of the video signal line has a side surface, the side surface tilts in a first angle to the normal direction of the TFT substrate so that side surface faces a major surface of the liquid crystal layer.

4. The liquid crystal display device according to claim 3, wherein the first angle is 15 degree or more.

5. The liquid crystal display device according to claim 4, wherein the first angle is 45 degree or less.

6. The liquid crystal display device according to claim 2, wherein the side wall of the groove like recess has an angle with respect to the major surface of the TFT substrate,

the angle is 15 degree or more.

7. The liquid crystal display device according to claim 2, wherein the side wall of the groove like recess has an angle with respect to the major surface of the TFT substrate,

the angle is 45 degree or less.

8. The liquid crystal display device according to claim 1, wherein the groove like recess does not overlap with the scan line.

9. The liquid crystal display device according to claim 1, an insulating film is formed over the video signal line, a common electrode is formed on the insulating film, a common metal wiring is formed superposing with the video signal line in a plan view and contacts with the common electrode,

a width of the common metal wiring in a direction that the scan line extends is bigger than a width of the video signal line in the direction that the scan line extends.

10. The liquid crystal display device according to claim 9, wherein a thickness of the common metal wiring is smaller than a thickness of the video signal line.
11. The liquid crystal display device according to claim 10, wherein, on the counter substrate, a black matrix is formed superposing the video signal line in a plan view, a width of the black matrix in a direction that the scan line extends is bigger than a width of the video signal line in the direction that the scan line extends.
12. The liquid crystal display device according to claim 1, wherein a metal layer is formed superposing the groove like recess on a same layer as the scan line.
13. The liquid crystal display device according to claim 12, wherein the metal layer is made of the material that is the same as the scan line, and the metal layer is segmented by the scan line.
14. The liquid crystal display device according to claim 1, wherein a width of the metal layer in a direction that the scan line extends is the same or less than a width of the groove line recess in cross section in the direction that the scan line extends.
15. The liquid crystal display device according to claim 1, the liquid crystal display device is an IPS type liquid crystal display device.
16. A liquid crystal display device comprising: a TFT substrate including a plural scan lines and a plural video signal lines, a counter substrate opposing to the TFT substrate, and a liquid crystal layer sandwiched between the TFT substrate and the counter substrate, wherein the video signal line has a first portion that is in parallel with a major surface of the TFT substrate, and a second portion that includes an inclined portion with respect to the major surface of the TFT substrate, the first portion and the second portion are formed alternatively in a direction the video signal line extends.
17. The liquid crystal display device according to claim 16, wherein the first portion of the video signal line overlaps with the scan line, the second portion of the video signal line does not overlap with the scan line.
18. The liquid crystal display device according to claim 16, wherein an interlayer insulating film is formed between a first layer where the scan line is formed and a second layer where the video signal line is formed, a groove like recess is formed in the interlayer insulating film where the second portion of the video signal line overlaps.
19. The liquid crystal display device according to claim 18, wherein the groove like recess has an inclined portion that has an inclining angle between 15 degree and 45 degree with respect to the major surface of the TFT substrate.
20. The liquid crystal display device according to claim 18, wherein a metal layer is formed at a TFT substrate side of the groove like recess, the metal layer is formed on the first layer, the metal layer is electrically insulated from the scan line.

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专利名称(译)	液晶显示装置		
公开(公告)号	US20180364535A1	公开(公告)日	2018-12-20
申请号	US15/955724	申请日	2018-04-18
[标]申请(专利权)人(译)	株式会社日本显示器		
申请(专利权)人(译)	日本展示INC.		
当前申请(专利权)人(译)	日本展示INC.		
[标]发明人	SHIINA HIDEKI		
发明人	SHIINA, HIDEKI		
IPC分类号	G02F1/1362 G02F1/1368 G02F1/1333 G02F1/1335 G02F1/1343 H01L27/12		
CPC分类号	G02F1/136286 G02F1/1368 G02F1/133345 G02F1/133512 G02F1/134363 H01L27/124 H01L27/1248 G02F2001/136295 G02F2001/13685 G02F2201/123 H01L27/1262 H01L27/127 G02F2001/13629 H01L29/41733 H01L29/78645		
优先权	2017119484 2017-06-19 JP		
其他公开文献	US10495934		
外部链接	Espacenet USPTO		

摘要(译)

本发明的目的是防止线条形状的亮度不均匀并改善对比度。代表性结构如下。一种液晶显示装置，包括：TFT基板，包括多条扫描线和多条视频信号线;对置基板，与TFT基板相对;以及液晶层，夹在TFT基板和対置基板之间;其中，在扫描线和视频信号线之间形成层间绝缘膜，在与视频信号线重叠的层间绝缘膜中形成凹槽状凹槽。

